Search Notes



_	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10630194	KIM, CHAE-SUNG
	Examiner	Art Unit
	Henn, Timothy J	2622

	SEARCHED		
Class	Subclass	Date	Examiner
348	226.1-228.1,222.1,362-364,296-299	9/30/06	TJH
708	403-409	3/23/07	TJH

SEARCH NOTES				
Search Notes	Date	Examiner		
Consulted Yogesh Aggarwal, Peter Pappas Re: FFT and claims 5-13	9/30/06	TJH		
Consulted Vivek Srivastava Re: L in the claimed equations and ADC bit range; new matter	3/23/07	TJH		
Consulted Cuong Ngo Re: FFT circuit of figure 7 and claim 9 -> 708/403-409h	3/23/07	ТЈН		
Updated Search	3/23/07	TJH		

	CH	INTERFERENCE SEA	
Examine	Date	Subclass	Class
_	Date	Subclass	Class

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